Octal Schmitt trigger buffer/line driver; 3-state Rev. 6 — 16 December 2013

Product data sheet

## 1. General description

The 74HC7541; 74HCT7541 is an 8-bit buffer/line driver with Schmitt-trigger inputs and 3-state outputs. The device features two output enables (OE1 and OE2). A HIGH on OEn causes the outputs to assume a high-impedance OFF-state. Inputs include clamp diodes. This enables the use of current limiting resistors to interface inputs to voltages in excess of V<sub>CC</sub>. Schmitt trigger inputs transform slowly changing input signals into sharply defined jitter-free output signals.

## 2. Features and benefits

- Non-inverting outputs
- Low-power dissipation
- Input levels:
  - For 74HC7541: CMOS level
  - For 74HCT7541: TTL level
- Complies with JEDEC standard no. 7A
- ESD protection:
  - HBM JESD22-A114F exceeds 2000 V
  - MM JESD22-A115-A exceeds 200 V
- Multiple package options
- Specified from -40 °C to +85 °C and from -40 °C to +125 °C

## 3. Ordering information

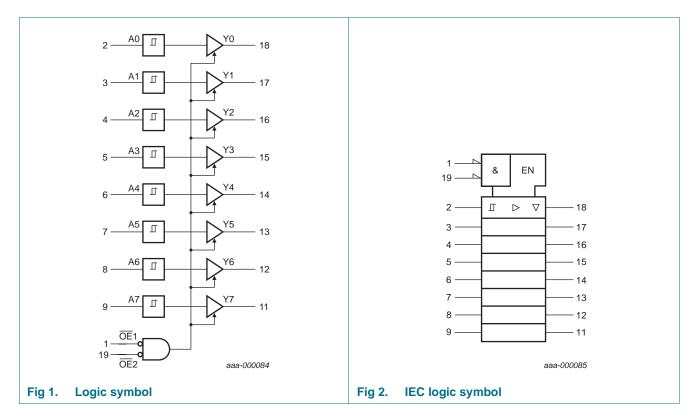
Table 1.	Ordering information
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Type number	Package				
	Temperature range	Name	Description	Version	
74HC7541N	–40 °C to +125 °C	DIP20	plastic dual in-line package; 20 leads (300 mil)	SOT146-1	
74HCT7541N					
74HC7541D	–40 °C to +125 °C	SO20	plastic small outline package; 20 leads;	SOT163-1	
74HCT7541D			body width 7.5 mm		
74HC7541DB	–40 °C to +125 °C	SSOP20	plastic shrink small outline package; 20 leads; body width 5.3 mm	SOT339-1	
74HC7541PW	–40 °C to +125 °C	TSSOP20	plastic thin shrink small outline package; 20 leads;	SOT360-1	
74HCT7541PW	HCT7541PW		body width 4.4 mm		

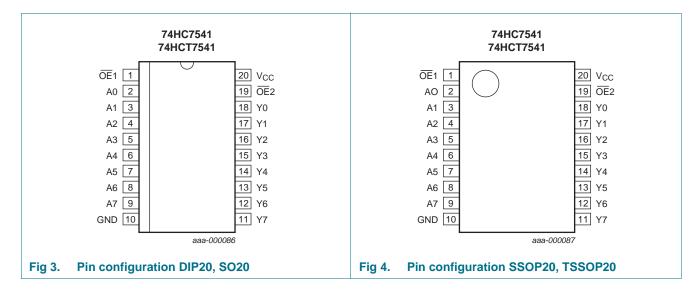


### Octal Schmitt trigger buffer/line driver; 3-state

## 4. Functional diagram



## 5. Pinning information



### 5.1 Pinning

### 5.2 Pin description

Table 2.	Pin description	
Symbol	Pin	Description
OE1	1	output enable input (active LOW)
A0 to A7	2, 3, 4, 5, 6, 7, 8, 9	data input
GND	10	ground (0 V)
Y0 to Y7	18, 17, 16, 15, 14, 13, 12, 11	data output
OE2	19	output enable input (active LOW)
V <sub>CC</sub>	20	supply voltage

### 6. Functional description

### Table 3.Functional table

Control		Input	Output
OE1	OE2	An	Yn
L	L	L	L
L	L	Н	Н
Х	Н	Х	Z
Н	Х	Х	Z

[1] H = HIGH voltage level; L = LOW voltage level; X = don't care; Z = high-impedance OFF-state.

## 7. Limiting values

#### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		-0.5	+7	V
I <sub>IK</sub>	input clamping current	$V_{\rm I}$ < –0.5 V or $V_{\rm I}$ > $V_{\rm CC}$ + 0.5 V	[1] _	±20	mA
I <sub>OK</sub>	output clamping current	$V_{\rm O}$ < –0.5 V or $V_{\rm O}$ > $V_{\rm CC}$ + 0.5 V	[1] _	±20	mA
lo	output current	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$	-	±35	mA
I <sub>CC</sub>	supply current		-	70	mA
I <sub>GND</sub>	ground current		-70	-	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	total power dissipation		[2]		
	DIP20		-	750	mW
	SO20, SSOP20, TSSOP20		-	500	mW

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] For DIP20 packages: above 70  $^\circ\text{C}$  the value of P<sub>tot</sub> derates linearly with 12 mW/K.

For SO20 packages: above 70 °C the value of Ptot derates linearly with 8 mW/K.

For SSOP20 and TSSOP20 packages: above 60 °C the value of Ptot derates linearly with 5.5 mW/K.

## 8. Recommended operating conditions

#### Table 5. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V)

Symbol	Parameter	Conditions	74HC7541			74HCT7541			Unit
			Min	Тур	Max	Min	Тур	Max	
V <sub>CC</sub>	supply voltage		2.0	5.0	6.0	4.5	5.0	5.5	V
VI	input voltage		0	-	$V_{CC}$	0	-	$V_{CC}$	V
Vo	output voltage		0	-	$V_{CC}$	0	-	$V_{CC}$	V
T <sub>amb</sub>	ambient temperature		-40	+25	+125	-40	+25	+125	°C

## 9. Static characteristics

### Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T <sub>ar</sub>	<sub>nb</sub> = 25	°C		-40 °C 85 °C	T <sub>amb</sub> = –40 °C to +125 °C		Unit
			Min	Тур	Max	Min	Max	Min	Max	
74HC754	41									
V <sub>OH</sub>	HIGH-level	$V_I = V_{T+} \text{ or } V_{T-}$								
	output voltage	$I_O = -20 \ \mu\text{A}; \ V_{CC} = 2.0 \ \text{V}$	1.9	2.0	-	1.9	-	1.9	-	V
		$I_O = -20 \ \mu\text{A}; \ V_{CC} = 4.5 \ \text{V}$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_O = -20 \ \mu\text{A}; \ V_{CC} = 6.0 \ \text{V}$	5.9	6.0	-	5.9	-	5.9	-	V
		$I_{O}$ = -6.0 mA; $V_{CC}$ = 4.5 V	3.98	4.32	-	3.84	-	3.7	-	V
		$I_{O}$ = -7.8 mA; $V_{CC}$ = 6.0 V	5.48	5.81	-	5.34	-	5.2	-	V
V <sub>OL</sub>	LOW-level	$V_I = V_{T+} \text{ or } V_{T-}$								
C	output voltage	$I_O = 20 \ \mu\text{A}; \ V_{CC} = 2.0 \ V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 20 \ \mu\text{A}; V_{CC} = 4.5 \ \text{V}$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 20 \ \mu\text{A}; \ V_{CC} = 6.0 \ V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O$ = 6.0 mA; $V_{CC}$ = 4.5 V	-	0.15	0.26	-	0.33	-	0.4	V
		$I_{O}$ = 7.8 mA; $V_{CC}$ = 6.0 V	-	0.16	0.26	-	0.33	-	0.4	V
l <sub>l</sub>	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0$ V	-	-	±0.1	-	±1.0	-	±1.0	μA
I <sub>OZ</sub>	OFF-state output current	per input pin; $V_I = V_{T+}$ or $V_{T-}$ ; $V_O = V_{CC}$ or GND; other inputs at $V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$ ; $I_O = 0 \text{ A}$	-	-	±0.5	-	±5.0	-	±10	μΑ
I <sub>CC</sub>	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 6.0$ V	-	-	8.0	-	80	-	160	μA
CI	input capacitance		-	3.5	-	-	-	-	-	pF
74HCT7	541									
V <sub>OH</sub>	HIGH-level	$V_{I}$ = $V_{T+}$ or $V_{T-};V_{CC}$ = 4.5 V								
	output voltage	I <sub>O</sub> = -20 μA	4.4	4.5	-	4.4	-	4.4	-	V
		$I_{O} = -6.0 \text{ mA}$	3.98	4.32	-	3.84	-	3.7	-	V

#### Table 6. Static characteristics ... continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T <sub>amb</sub> = 25 °C			- –40 °C 85 °C	T <sub>amb</sub> = −40 °C to +125 °C		Unit	
			Min	Тур	Max	Min	Max	Min	Max	
V <sub>OL</sub>	LOW-level	$V_{I}$ = $V_{T+}$ or $V_{T-};V_{CC}$ = 4.5 V								
	output voltage	I <sub>O</sub> = 20 μA;	-	0	0.1	-	0.1	-	0.1	V
		l <sub>O</sub> = 6.0 mA;	-	0.15	0.26	-	0.33	-	0.4	V
l <sub>l</sub>	input leakage current	$V_{I} = V_{CC}$ or GND; $V_{CC} = 5.5$ V	-	-	±0.1	-	±1.0	-	±1.0	μA
I <sub>OZ</sub>	OFF-state output current	per input pin; $V_I = V_{T+}$ or $V_{T-}$ ; $V_O = V_{CC}$ or GND; other inputs at $V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$ ; $I_O = 0 \text{ A}$	-	-	±0.5	-	±5.0	-	±10	μΑ
I <sub>CC</sub>	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5$ V	-	-	8.0	-	80	-	160	μΑ
ΔI <sub>CC</sub>	additional supply current	per input pin; I <sub>O</sub> = 0 A; V <sub>I</sub> = V <sub>CC</sub> - 2.1 V; other inputs at V <sub>CC</sub> or GND; V <sub>CC</sub> = 4.5 V to 5.5 V								
		An input	-	20	72	-	90	-	98	μA
		OEn input	-	130	468	-	585	-	637	μA
CI	input capacitance		-	3.5	-	-	-	-	-	pF

## **10.** Dynamic characteristics

### Table 7. Dynamic characteristics

GND = 0 V;  $C_L = 50$  pF; for test circuit see <u>Figure 7</u>.

Symbol	Parameter	Conditions		Tar	<sub>nb</sub> = 25	°C	$T_{amb} = -40$ °	°C to +125 °C	Unit
				Min	Тур	Max	Max (85 °C)	Max (125 °C)	
74HC754	41								
t <sub>pd</sub>	propagation delay	An to Yn; see Figure 5	[1]						
		$V_{CC} = 2.0 V$		-	39	120	150	180	ns
		$V_{CC} = 4.5 V$		-	14	24	30	36	ns
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$		-	10	-	-	-	ns
		$V_{CC} = 6.0 V$		-	11	20	26	32	ns
t <sub>en</sub>	enable time	OEn to Yn; see Figure 6	[1]						
		$V_{CC} = 2.0 V$		-	44	160	200	240	ns
		$V_{CC} = 4.5 V$		-	16	32	40	48	ns
		$V_{CC} = 6.0 V$		-	13	27	34	41	ns
t <sub>dis</sub>	disable time	OEn to Yn; see Figure 6	[1]						
		$V_{CC} = 2.0 V$		-	58	160	200	240	ns
		$V_{CC} = 4.5 V$		-	21	32	40	48	ns
		$V_{CC} = 6.0 V$		-	17	27	34	41	ns

#### Table 7. Dynamic characteristics

GND = 0 V;  $C_L = 50$  pF; for test circuit see Figure 7.

Symbol	Parameter	Conditions		Tar	<sub>nb</sub> = 25	°C	T <sub>amb</sub> = -40 °	C to +125 °C	Unit
				Min	Тур	Max	Max (85 °C)	Max (125 °C)	
t <sub>t</sub>	transition time	see Figure 5	[2]						
		$V_{CC} = 2.0 V$		-	14	60	75	90	ns
		$V_{CC} = 4.5 V$		-	5	12	15	18	ns
		$V_{CC} = 6.0 V$		-	4	10	13	15	ns
C <sub>PD</sub>	power dissipation capacitance	per package; $V_I = GND$ to $V_{CC}$	<u>[3]</u>	-	30	-	-	-	pF
74HCT75	541								
t <sub>pd</sub>	propagation delay	An to Yn; see Figure 5	[1]						
		$V_{CC} = 4.5 V$		-	19	32	40	48	ns
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$		-	16	-	-	-	ns
t <sub>en</sub>	enable time	OEn to Yn; see Figure 6	[1]						
		$V_{CC} = 4.5 V$		-	18	32	40	48	ns
t <sub>dis</sub>	disable time	OEn to Yn; see Figure 6	[1]						
		$V_{CC} = 4.5 V$		-	20	32	40	48	ns
t <sub>t</sub>	transition time	$V_{CC}$ = 4.5 V; see <u>Figure 5</u>	[2]	-	5	12	15	18	ns
C <sub>PD</sub>	power dissipation capacitance	per package; V <sub>I</sub> = GND to V <sub>CC</sub> – 1.5 V	[3]	-	32	-	-	-	pF

t<sub>pd</sub> is the same as t<sub>PLH</sub> and t<sub>PHL</sub>.
 t<sub>en</sub> is the same as t<sub>PZL</sub> and t<sub>PZH</sub>.
 t<sub>dis</sub> is the same as t<sub>PLZ</sub> and t<sub>PHZ</sub>.

[2]  $t_t$  is the same as  $t_{THL}$  and  $t_{TLH}$ .

[3]  $C_{PD}$  is used to determine the dynamic power dissipation (P<sub>D</sub> in  $\mu$ W):

 $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum (C_L \times V_{CC}^2 \times f_o)$  where:

 $f_i$  = input frequency in MHz;

 $f_o = output$  frequency in MHz;

 $C_L$  = output load capacitance in pF;

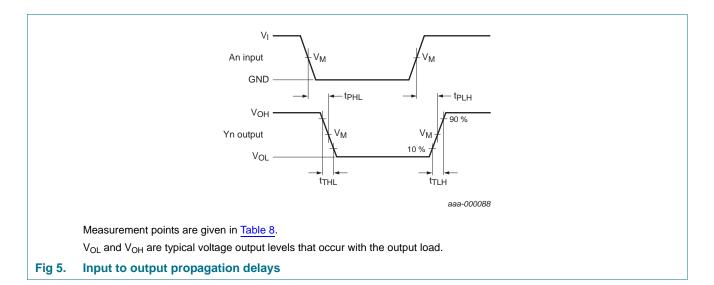
 $V_{CC}$  = supply voltage in V;

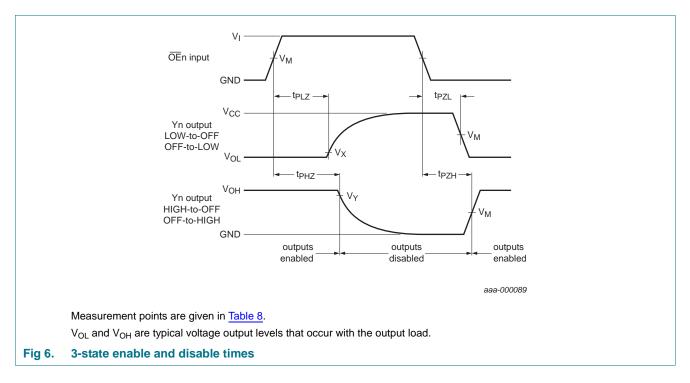
N = number of inputs switching;

 $\sum (C_L \times V_{CC}^2 \times f_o) = \text{sum of outputs.}$ 

Octal Schmitt trigger buffer/line driver; 3-state

## 11. Waveforms

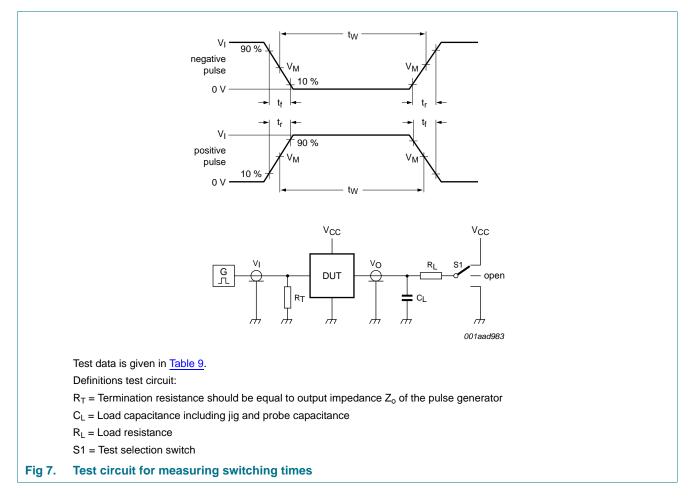




#### Table 8.Measurement points

Туре	Input	Output		
	V <sub>M</sub>	V <sub>M</sub>	V <sub>X</sub>	V <sub>Y</sub>
74HC7541	0.5V <sub>CC</sub>	0.5V <sub>CC</sub>	0.1V <sub>CC</sub>	0.9V <sub>CC</sub>
74HCT7541	1.3 V	1.3 V	0.1V <sub>CC</sub>	0.9V <sub>CC</sub>

### Octal Schmitt trigger buffer/line driver; 3-state



#### Table 9. Test data

Туре	Input		Load	Load		S1 position			
	VI	t <sub>r</sub> , t <sub>f</sub>	CL	RL	t <sub>PHL</sub> , t <sub>PLH</sub>	t <sub>PZH</sub> , t <sub>PHZ</sub>	t <sub>PZL</sub> , t <sub>PLZ</sub>		
74HC7541	V <sub>CC</sub>	6 ns	15 pF, 50 pF	1 kΩ	open	GND	V <sub>CC</sub>		
74HCT7541	3 V	6 ns	15 pF, 50 pF	1 kΩ	open	GND	V <sub>CC</sub>		

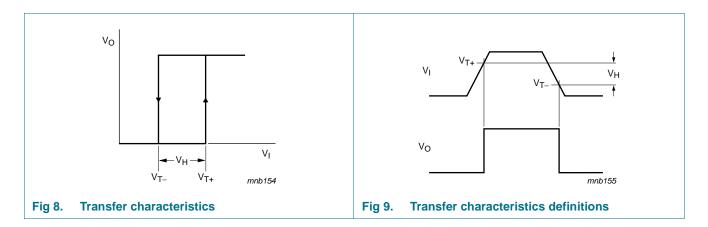
## **12. Transfer characteristics**

#### Table 10. Transfer characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); see Figure 8 and Figure 9.

Symbol	Parameter	Conditions	Tai	T <sub>amb</sub> = 25 °C		T <sub>amb</sub> = -40 °C to +85 °C		T <sub>amb</sub> = -40 °C to +125 °C		Unit
			Min	Тур	Max	Min	Max	Min	Max	
74HC754	41									
V <sub>T+</sub>	positive-going threshold voltage	V <sub>CC</sub> = 2.0 V	-	-	1.5	-	1.5	-	1.5	V
		V <sub>CC</sub> = 4.5 V	-	-	3.15	-	3.15	-	3.15	V
		V <sub>CC</sub> = 6.0 V	-	-	4.2	-	4.2	-	4.2	V
V <sub>T-</sub>	negative-going threshold voltage	V <sub>CC</sub> = 2.0 V	0.3	-	-	0.3	-	0.3	-	V
		V <sub>CC</sub> = 4.5 V	1.35	-	-	1.35	-	1.35	-	V
		V <sub>CC</sub> = 6.0 V	1.8	-	-	1.8	-	1.8	-	V
V <sub>H</sub>	hysteresis voltage	V <sub>CC</sub> = 2.0 V	0.1	0.20	-	0.1	-	0.1	-	V
		V <sub>CC</sub> = 4.5 V	0.25	0.40	-	0.25	-	0.25	-	V
		V <sub>CC</sub> = 6.0 V	0.3	0.5	-	0.3	-	0.3	-	V
74HCT7	541									
V <sub>T+</sub>	positive-going threshold voltage	V <sub>CC</sub> = 4.5 V	-	-	2.0	-	2.0	-	2.0	V
		V <sub>CC</sub> = 5.5 V	-	-	2.1	-	2.1	-	2.1	V
V <sub>T-</sub>	negative-going threshold voltage	$V_{CC} = 4.5 V$	0.7	-	-	0.64	-	0.6	-	V
		V <sub>CC</sub> = 5.5 V	0.8	-	-	0.74	-	0.7	-	V
V <sub>H</sub>	hysteresis voltage	$V_{CC} = 4.5 V$	0.17	0.23	-	-	-	-	-	V
		V <sub>CC</sub> = 5.5 V	0.17	0.23	-	-	-	-	-	V

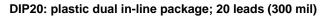
## 13. Transfer characteristics waveforms

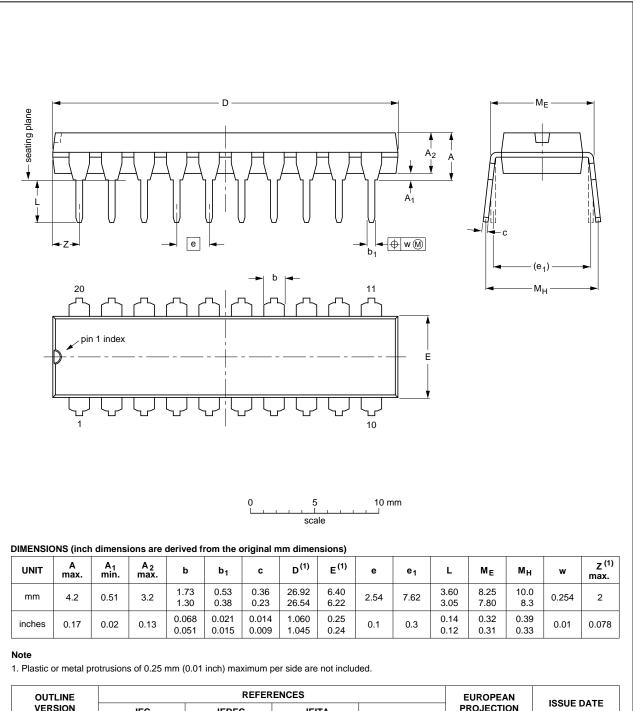


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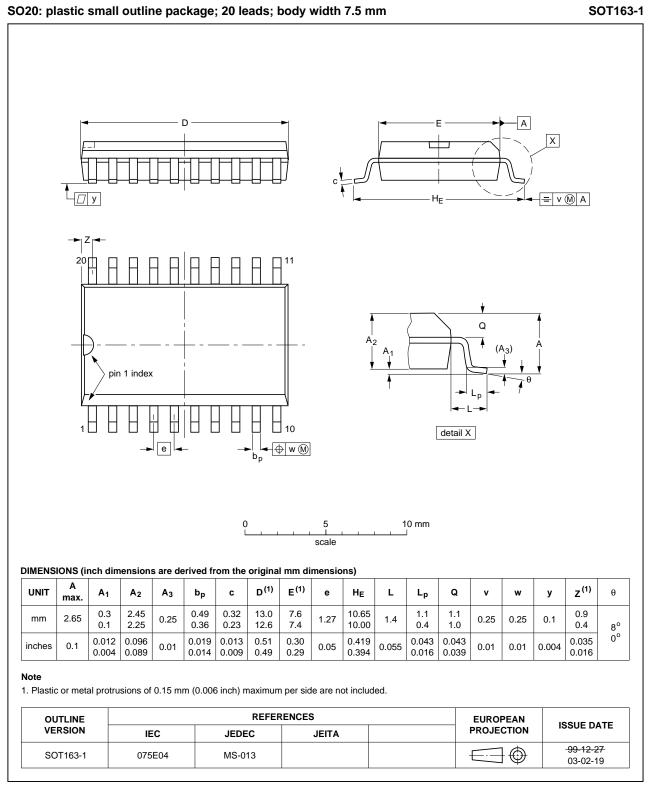
SOT146-1

## 14. Package outline



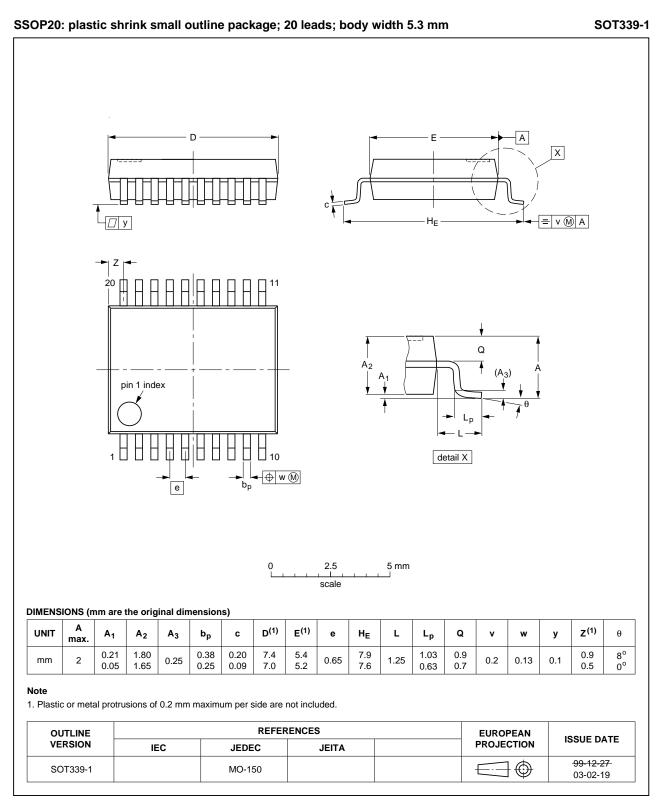


### Octal Schmitt trigger buffer/line driver; 3-state



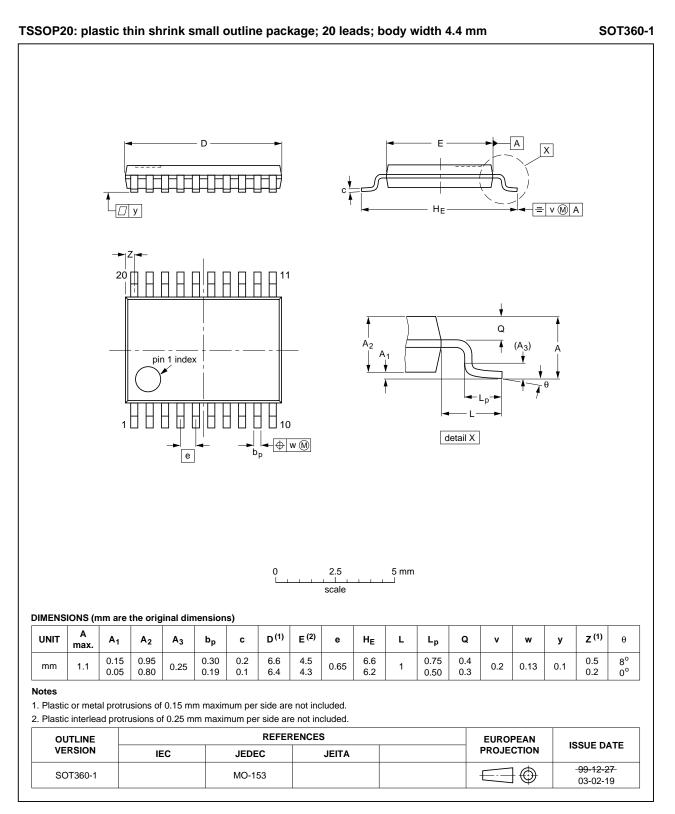
### Fig 11. Package outline SOT163-1 (SO20)

### Octal Schmitt trigger buffer/line driver; 3-state



### Fig 12. Package outline SOT339-1 (SSOP20)

### Octal Schmitt trigger buffer/line driver; 3-state



#### Fig 13. Package outline SOT360-1 (TSSOP20)

## **15. Abbreviations**

Table 11. Abbreviations				
Acronym	Description			
CMOS	Complementary Metal-Oxide Semiconductor			
DUT	Device Under Test			
ESD	ElectroStatic Discharge			
HBM	Human Body Model			
LSTTL	Low-power Schottky Transistor-Transistor Logic			
MM	Machine Model			

## 16. Revision history

### Table 12.Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT7541 v.6	20131216	Product data sheet	-	74HC_HCT7541 v.5
Modifications:	<ul> <li>New general</li> </ul>	description (errata).		
74HC_HCT7541 v.5	20121231	Product data sheet	-	74HC_HCT7541 v.4
Modifications:	<ul> <li>I<sub>OZ</sub> added to</li> </ul>	static characteristics table.		
74HC_HCT7541 v.4	20111219	Product data sheet	-	74HC_HCT7541 v.3
Modifications:	<ul> <li>Legal pages</li> </ul>	updated.		
74HC_HCT7541 v.3	20110725	Product data sheet	-	74HC_HCT7541_CNV v.2
74HC_HCT7541_CNV v.2	19970917	Product specification	-	-

## 17. Legal information

### 17.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

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